of 2



Application/Control No.	Applicant(s)/Patent under Reexamination	
09/820,453	BORG ET AL.	
Examiner	Art Unit	
Tamara L. Gravsav	3623	

SEARCHED			
Class	Subclass	Date	Examiner
705	10, 11 (update)	9/26/2005	ТG
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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		<del></del>		
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SEARCH NO (INCLUDING SEARCH		_ <del></del> )
	DATE	EXMR
DIALOG search - printout attached	9/27/2005	TG
consulted R.Jeanty, AU3623	9/27/2005	TG
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Set	Items	Description
S1	23769805	MARKETING OR SALES
S2	14117619	SOLUTION OR PLAN OR SCHEME OR INITIATIVE
S3	421388	S1 (7N) S2
S4	318388	PRODUCT (3N) (USE OR USAGE)
S5	5325	S3 AND S4
S6	1087	S5 AND (PRINT OR PRINTING OR COPY OR COPIER OR COPYING)
S7	1	S6 AND (RECYCLE OR REPLACE OR REPLACEABLE) (2N) COMPONENT

## Multiple databases searched: FullText\_

- 9: Business & Industry
- 15: ABI/INFORM
- 16, 160: PROMT, Gale
- 20: Global Reporter, Gale
- 148: Trade & Industry Database, Gale
- 275: Computer Database, Gale
- 476: Financial Times
- 610,810: Business Wire
- 613,813: PR Newswire
- 621: New Product Announcements/Plus, Gale
- 624: McGraw-Hill Companies Pubs Online
- 634: San Jose Mercury News
- 636: Newsletter Database, Gale Group

## Software and Technology Oriented

■ 256: Softbase: Reviews, Companies, Products

## NonFullText

- 2: INSPEC
- 35: Dissertation Abstracts Online
- 65: Inside Conferences
- 99: Wilson Applied Science & Tech Abstracts
- 474: New York Times Abstracts
- 475: Wall Street Journal Abstracts
- 583: Globalbase, Gale Group

## Group G

- □ 6: NTIS-Nat'l Technical Information Service
- □ 7: Social SciSearch
- □ 8: Ei Compendex
- □ 34, 434: SciSearch
- 94: JICST-Eplus Japanese Science & Tech